

**Search Notes**

Application/Control No.

10/089,498

Examiner

Young J. Kim

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner
435	6	5/27/2005	YJK
	91.1	5/27/2005	YJK
	91.2	5/27/2005	YJK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	5/27/2005	YJK
See enclosed for search strategy	5/27/2005	YJK